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 Tammaru, E.; Angell, J.B.;
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- ☐ **2. Interstitial redundancy: an area efficient fault tolerance scheme for large area VLSI process**
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- ☐ **3. On yield consideration for the design of redundant programmable logic arrays**
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-  **25. RAID5 performance with distributed sparing**
Thomasian, A.; Jai Menon;
Parallel and Distributed Systems, IEEE Transactions on
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Sanders, D.A.; Cremaldi, L.M.; Eschenburg, V.; Lawrence, C.N.; Riley, C.; Summers, D.J.; Petravic
Nuclear Science, IEEE Transactions on
Volume 49, Issue 4, Part 1, Aug. 2002 Page(s):1834 - 1840
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Marcheschi, P.; Positano, V.; Ferdeghini, E.M.; Mazzarisi, A.; Benassi, A.;
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Nuclear Science Symposium Conference Record, 2001 IEEE
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Power Engineering Society 1999 Winter Meeting, IEEE
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